

Form PTO-1449

## INFORMATION DISCLOSURE CITATION

## IN AN APPLICATION

(Use several sheets if necessary)

MAY 21 2001

Docket Number (Optional)

LLE-007.01 (21379-701)

Application Number

09/744,148

Applicant  
Elstein et al.

Filing Date

January 29, 2001

Group Art Unit

To Be Assigned 2878

## U.S. PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
SL	AA	4,731,881	03/15/88	Geller	455	619	06/30/86
SL	AB	5,021,668	06/04/91	Talmore et al.	250	372	01/16/90
SL	AC	5,148,023	09/15/92	Hayashi et al.	250	372	04/09/90
SL	AD	5,719,567	02/17/98	Norris	340	953	05/30/95

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						YES	NO
SL	AE	GB 2 278 435	11/30/94	UK	—	—	X
SL	AF	CA 2,11,490	01/28/98	Canada	—	—	X

## OTHER DOCUMENTS

(Including Author, Title, Date, Pertinent Pages Etc.)

	AO	Lindner et al.; "Solar Blind Bandpass Filters for UV Imaging Devices", SPIE Electronic Imaging 3302, PP. 176-183, (1998)
SL	AH	Lindner et al.; "UV Devices for Solar Blind & Background Limited Detection", SPIE, VOL. 3110, PP. 527-534, (1997)
SL	AI	Grum and Costa, "Spectral Emission of Corona Discharges", Applied Optics 15(1): 76-79 (January 1976)
SL	AJ	Qiang Gui Wang, "Detecting and enhancing Latent Fingerprints with Short Wave UV Reflection Photography", Proc. Of the Symposium on Fingerprint Detection and Identification, Neurim( IsrAEL), pp. 37-49, (June 1995)
SL	AK	Springer et al.; "Detection of Dry Body Fluids by Inherent Short Wavelength UV Luminescence: Preliminary Results", Forensic Science International, 66: 89-94 (1994).
SL	AL	Teich H. T.; "Location of Corona Points By Detection of Their UV Emission", Conference on Diagnostic Testing of High Voltage Systems No. 1215109, pp. 26-30, (1973)
SL	AM	Vosloo et al; "Daylight Corona Discharge Observation and Recording System", 10 <sup>th</sup> International Symposium on High Voltage Engineering, (August 25-29, 1997)

EXAMINER

DATE CONSIDERED

SL Lee

2/17/04

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.